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Application/Control No.	Applicant(s)/Patent under Reexamination
10/512,051	ITO ET AL.
Examiner	Art Unit
Roberto Velez	2829

SEARCHED				
Class	Subclass	Date	Examiner	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Search:(US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) PLUS Search and Text Search (See Search History)	10/12/2006	RV		